

# **STGD7NB120S-1**

# N-CHANNEL 7A - 1200V IPAK Power MESH<sup>TM</sup> IGBT

TYPE	V <sub>CES</sub>	V <sub>CE(sat)</sub>	I <sub>C</sub>
STGD7NB120S-1	1200 V	< 2.1 V	7 A

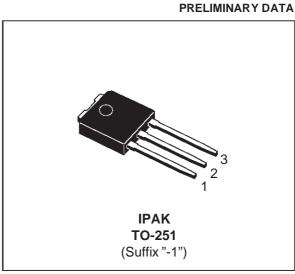
- HIGH INPUT IMPEDANCE (VOLTAGE DRIVEN)
- VERY LOW ON-VOLTAGE DROP (Vcesat)
- HIGH CURRENT CAPABILITY
- OFF LOSSES INCLUDE TAIL CURRENT

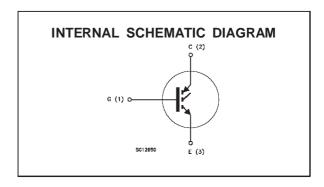
#### **DESCRIPTION**

Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH<sup>TM</sup> IGBTs, with outstanding perfomances. The suffix "S" identifies a family optimized to achieve minimum on-voltage drop for low frequency applications (<1kHz).

#### **APPLICATIONS**

- LIGHT DIMMER
- INRUSH CURRENT LIMITATION
- MOTOR CONTROL





#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-Emitter Voltage (V <sub>GS</sub> = 0)	1200	V
V <sub>ECR</sub>	Reverse Battery Protection	20	V
$V_{GE}$	Gate-Emitter Voltage	± 20	V
Ic	Collector Current (continuous) at T <sub>c</sub> = 25 °C	10	А
Ic	Collector Current (continuous) at T <sub>c</sub> = 100 °C	7	А
I <sub>CM</sub> (●)	Collector Current (pulsed)	20	А
P <sub>tot</sub>	Total Dissipation at T <sub>c</sub> = 25 °C	55	W
	Derating Factor	0.4	W/°C
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

(•) Pulse width limited by safe operating area

1/6 April 2000

### THERMAL DATA

R <sub>thj-case</sub>	Thermal	Resistance	Junction-case	Max	2.27	°C/W
R <sub>thj-amb</sub>	Thermal	Resistance	Junction-ambient	Max	100	°C/W
R <sub>thc-sink</sub>	Thermal	Resistance	Case-sink	Тур	1.5	°C/W

# **ELECTRICAL CHARACTERISTICS** ( $T_j = 25\,^{\circ}\text{C}$ unless otherwise specified)

OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V <sub>BR(CES)</sub>	Collector-Emitter Breakdown Voltage	$I_C = 250 \ \mu A$ $V_{GE} = 0$	1200			V
V <sub>BR(ECR)</sub>	Emitter-Collector Breakdown Voltage	IC = 10 mA V <sub>GE</sub> = 0	20			V
I <sub>CES</sub>	Collector cut-off (V <sub>GE</sub> = 0)	$V_{CE} = Max Rating$ $T_j = 25  ^{\circ}C$ $V_{CE} = 0.8 Max Rating$ $T_j = 125  ^{\circ}C$			250 1000	μΑ μΑ
IGES	Gate-Emitter Leakage Current (V <sub>CE</sub> = 0)	$V_{GE} = \pm 20 \text{ V}$ $V_{CE} = 0$			± 100	nA

# ON (\*)

Symbol	Parameter	Test Conditions		Тур.	Max.	Unit
V <sub>GE(th)</sub>	Gate Threshold Voltage	V <sub>CE</sub> = V <sub>GE</sub> I <sub>C</sub> = 250 μA	3		5	V
$V_{GE}$	Gate Emitter Voltage	$V_{CE} = 2.5V$ $I_{C} = 2A$ $T_{j} = 25 \div 125$ °C			6.5	V
V <sub>CE(SAT)</sub>	Collector-Emitter Saturation Voltage	$V_{GE} = 15 \text{ V}$ $I_{C} = 3.5 \text{ A}$ $V_{GE} = 15 \text{ V}$ $I_{C} = 7 \text{ A}$ $V_{GE} = 15 \text{ V}$ $I_{C} = 10 \text{ A}$		1.7	1.6 2.1	V V V

### **DYNAMIC**

Symbol	Parameter	Test Conditions	N	/lin.	Тур.	Max.	Unit
<b>g</b> fs	Forward Transconductance	$V_{CE} = 25 \text{ V}$ $I_C = 7 \text{ A}$	2	2.5	4.5		S
C <sub>ies</sub> C <sub>oes</sub> C <sub>res</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{CE} = 25 \text{ V}$ f = 1 MHz $V_{G}$	<sub>BE</sub> = 0		430 40 7		pF pF pF
$Q_{G}$	Gate Charge	$V_{CE} = 960 \text{ V}  I_{C} = 7 \text{ A}  V_{G}$	<sub>SE</sub> = 15 V		29		nC
I <sub>CL</sub>	Latching Current	$V_{clamp} = 960 \text{ V}$ R T <sub>j</sub> = 150 °C	R <sub>G</sub> =1kΩ	10			А

## SWITCHING ON

Symbol	Parameter	Test Conditions			Тур.	Max.	Unit
t <sub>d(on)</sub>	Delay Time	V <sub>CC</sub> = 960 V	I <sub>C</sub> = 7 A		570		ns
t <sub>r</sub>	Rise Time	V <sub>GE</sub> = 15 V	$R_G = 1 K\Omega$		270		ns
(di/dt) <sub>on</sub>	Turn-on Current Slope	V <sub>CC</sub> = 960 V	I <sub>C</sub> = 7 A		800		A/μs
		$R_G = 1 K\Omega$	$V_{GE} = 15 \text{ V}$				
Eon	Turn-on	T <sub>j</sub> = 125 °C			3.2		mJ
	Switching Losses						

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# **ELECTRICAL CHARACTERISTICS** (continued)

### **SWITCHING OFF**

Symbol	Parameter	Test Conditions		Тур.	Max.	Unit
$t_{c} \\ t_{r}(v_{off}) \\ t_{f} \\ E_{off}(**)$	Cross-Over Time Off Voltage Rise Time Fall Time Turn-off Switching Loss	$V_{CC} = 960 \text{ V}$ $I_{C} = 7 \text{ A}$ $V_{GE} = 1000 \Omega$ $V_{GE} = 15$		4.9 2.9 3.3 15		μs μs μs mJ
$t_{c} \\ t_{r}(v_{off}) \\ t_{f} \\ E_{off}(**)$	Cross-Over Time Off Voltage Rise Time Fall Time Turn-off Switching Loss	$V_{CC} = 960 \text{ V}$ $I_{C} = 7 \text{ A}$ $R_{GE} = 1000 \Omega$ $V_{GE} = 15$ $T_{j} = 125  ^{\circ}\text{C}$		7.5 5.5 6.2 22		μs μs μs mJ

<sup>(\*)</sup> Pulse width limited by safe operating area
(\*) Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %
(\*\*)Losses Include Also The Tail (Jedec Standardization)

Fig. 1: Gate Charge test Circuit

Fig. 2: Test Circuit For Inductive Load Switching

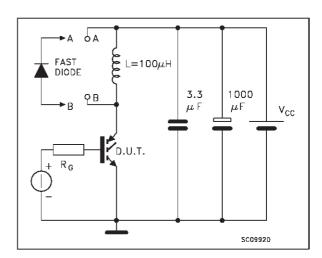
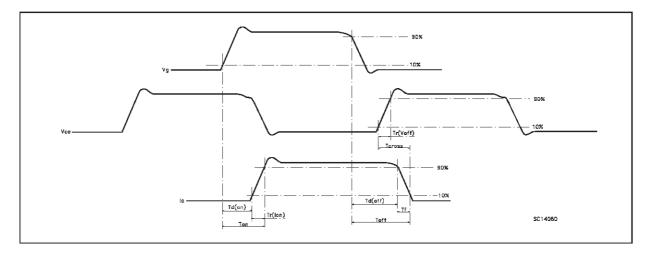


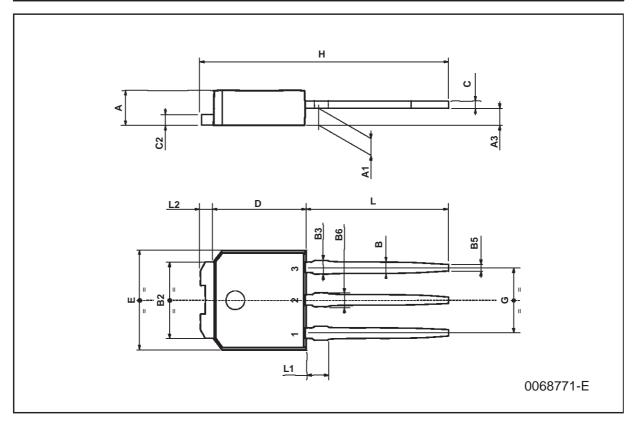
Fig. 3: Switching Waveforms



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# TO-251 (IPAK) MECHANICAL DATA

DIM.		mm			inch	
DIN.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
А3	0.7		1.3	0.027		0.051
В	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
В3			0.85			0.033
B5		0.3			0.012	
В6			0.95			0.037
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
Е	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
Н	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	1		0.031	0.039



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